

10/1
9861
7943

U.S. UTILITY Patent Application

APPL NUM 10008392	FILING DATE 11/13/2001	CLASS 374	SUBCLASS 045	GAU 2859	EXAMINER DE JESUS
**APPLICANTS: Pavidis Ioannis;					
**CONTINUING DATA VERIFIED: THIS APPLN CLAIMS BENEFIT OF 60/285,004 04/19/2001					
BEST AVAILABLE COPY					
** FOREIGN APPLICATIONS VERIFIED:					
PG-PUB <input type="checkbox"/> DO NOT PUBLISH <input type="checkbox"/>		RESCIND <input type="checkbox"/>			
Foreign priority claimed <input type="checkbox"/> yes <input type="checkbox"/> no		35 USC 119 conditions met <input type="checkbox"/> yes <input type="checkbox"/> no		ATTORNEY DOCKET NO.	
Verified and Acknowledged Examiners's initials		H0002443-01			
TITLE : System and method using thermal image analysis for polygraph testing					
<small>U.S. DEPT. OF COMM./PAT. & TM.-PTO-435L (Rev. 12-94)</small>					
BEST AVAILABLE COPY					

NOTICE OF ALLOWANCE MAILED		Assistant Examiner		CLAIMS ALLOWED	
				Total Claims	Print Claim for O.G.
ISSUE FEE		Primary Examiner		DRAWING	
Amount Due	Date Paid			Sheets Drwg.	Figs. Drwg.
<input type="checkbox"/> TERMINAL DISCLAIMER		PREPARED FOR ISSUE		Application Examiner	
WARNING: The information disclosed herein may be restricted. Unauthorized disclosure may be prohibited by the United States Code Title 35, Sections 122, 181 and 368, Possession outside the U.S. Patent & Trademark Office is restricted to authorized employees and contractors only.					

FILED WITH: ☐ DISK (CRF) ☐ CD-ROM
(Attached in pocket on right inside flap)